Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/702,505	KWON, HAE WOOK	
Examiner	Art Unit	
Toan C. To	3616	

SEARCHED			
Class	Subclass	Date	Examiner
280	732	12/5/2005	тт
280	739	12/5/2005	TT
280	743.1	12/5/2005	Π
280	743.2	12/5/2005	π

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Text search (see noted search)	12/5/2005	π
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